

P-Channel 25-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^{a, e}	Q _g (Typ.)			
- 25	0.100 at V _{GS} = - 10 V	- 3.0	7 nC			
	0.110 at V _{GS} = - 4.5 V	- 2.6				

TO-236 (SOT-23)

Top View

FEATURES

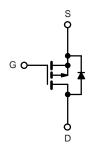
• Halogen-free According to IEC 61249-2-21 Definition



- Trench Power MOSFET
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Load Switch
- Notebook Adaptor Switch
- DC/DC Converter



P-Channel MOSFET

Davamatar		unless otherwise		l lmit
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	- 25	V
Gate-Source Voltage		V_{GS}	± 20	V
	T _C = 25 °C		-3.0	
Continuous Drain Current (T. 150 °C)	T _C = 70 °C		- 2.7	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	- 3.2 ^{b, c}	
	T _A = 70 °C		- 2.3 ^{b, c}	A
Pulsed Drain Current		I _{DM}	- 15	
0 11 0 0 0 1	T _C = 25 °C		- 2.1	
Continous Source-Drain Diode Current	T _A = 25 °C	- I _S	- 1 ^{b, c}	
	T _C = 25 °C		2.5	
Maximum Power Dissipation	T _C = 70 °C		1.6	10/
	T _A = 25 °C	P _D	1.25 ^{b, c}	W
	T _A = 70 °C		0.8 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	75	100	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	40	50	C/VV		

- a. Based on T_C = 25 °C.
 b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 166 °C/W.
- e. Package Limited.



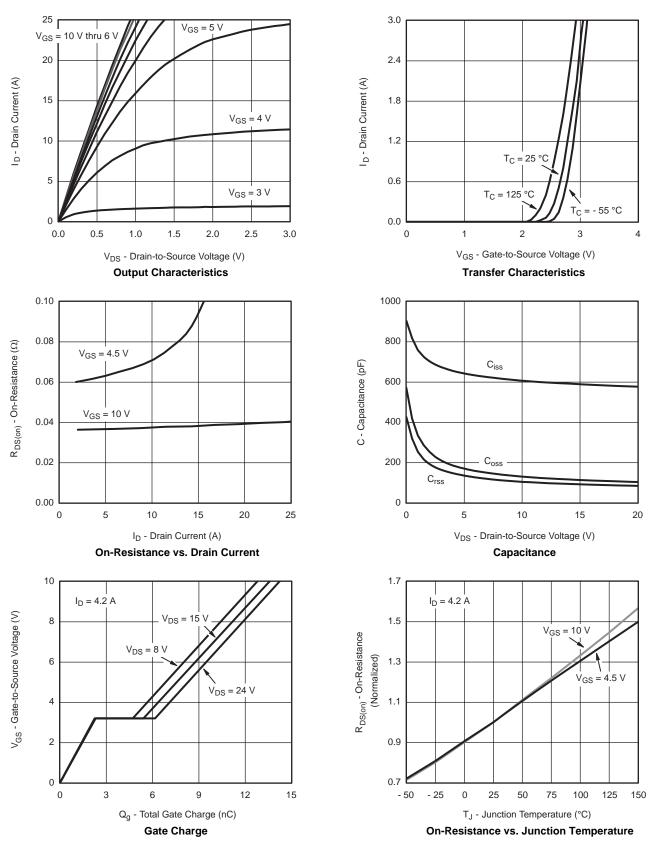
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-				l		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	- 25			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250A		- 19		1400	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4.4		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	- 1.0		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0		V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 25			Α	
D : 0	Б	V _{GS} = - 10 V, I _D = - 4.2 A		0.100			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 3.2 A		0.110		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 4.2 A		10		S	
Dynamic ^b				l	L	ı	
Input Capacitance	C _{iss}			590			
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		115		pF	
Reverse Transfer Capacitance	C _{rss}	1		93			
·	0	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 4.2 A		13.6	21		
Total Gate Charge	Q _g			7	11		
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4.2 \text{ A}$		2.3			
Gate-Drain Charge	Q_{gd}]		3.2			
Gate Resistance	R_g	f = 1 MHz	1	5	10	Ω	
Turn-On Delay Time	t _{d(on)}			30	45		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 4.5 \Omega$		25	38		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 3.3 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		16	24	1	
Fall Time	t _f]		8	16	1	
Turn-On Delay Time	t _{d(on)}			8	16	ns	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 4.5 \Omega$		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 3.3 A, V_{GEN} = - 10 V, R_g = 1 Ω		18	27		
Fall Time	t _f]		8	16		
Drain-Source Body Diode Characteristi	cs			•			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 4.2	۸	
Pulse Diode Forward Current	I _{SM}				- 25	A	
Body Diode Voltage	V_{SD}	I _S = - 3.3 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			17	26	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 3.3 A, dI/dt = 100 A/μs, T _J = 25 °C		9	18	nC	
Reverse Recovery Fall Time	t _a	i _F = -3.3 A, αί/αι = 100 A/μs, 1 _J = 25 °C		10			
Reverse Recovery Rise Time	t _b	_		7		ns	

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

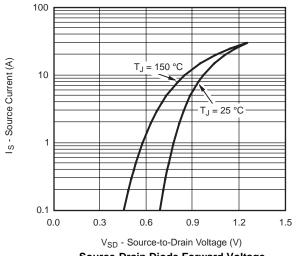


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

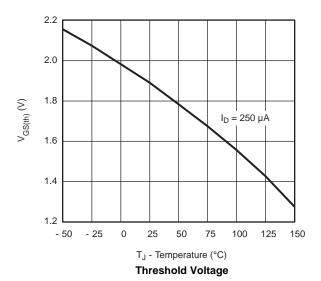




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

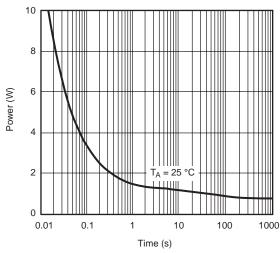




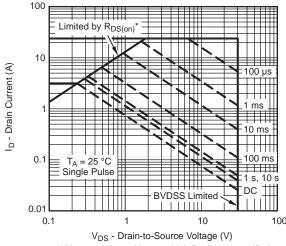


0.10 $I_D = 4.2 A$ R_{DS(on)} - On-Resistance (Ω) 0.08 T_J = 125 °C 0.06 $T_J = 25$ °C 0.04 0.02 2

V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)

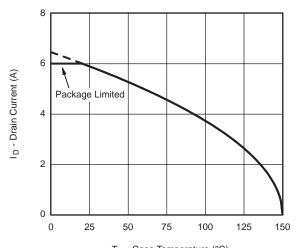


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

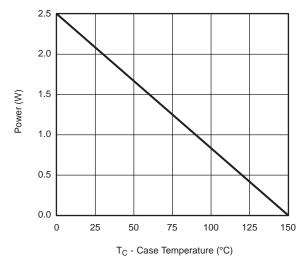


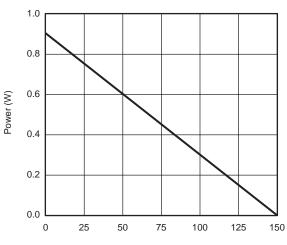
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





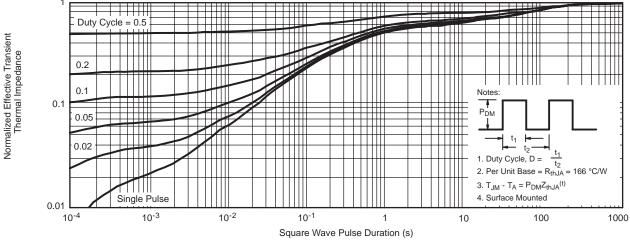
T_A - Ambient Temperature (°C)

Power, Junction-to-Foot Power, Junction-to-Ambient

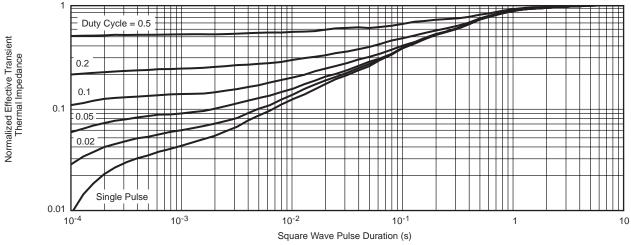
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

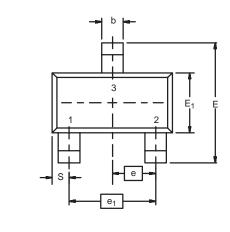
Note

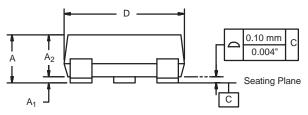
- The characteristics shown in the two graphs Normalized Transient Thermal Impedance Junction-to-Ambient (25 $^{\circ}\text{C})$
 - Normalized Transient Thermal Impedance Junction-to-Foot (25 °C)

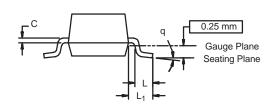
are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



SOT-23 (TO-236): 3-LEAD







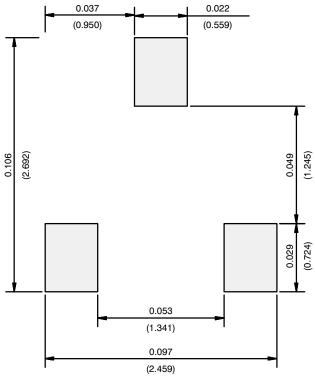
Dim -	MILLIN	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
Е	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
q ECN: S-03946-Rev. K. 09-		8°	3°	8°	

DWG: 5479

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RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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